		Application/Control No.	Applicant(s)/Patent Under Reexamination
Notice of References Cited		09/686,115	AGGARWAL ET AL.
		Examiner	Art Unit	
		Kelvin E Booker	2121	Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,121,338	06-1992	Lodder, Robert A.	702/30
	B	US-5,263,120	11-1993	Bickel, Michael A.	706/62
	C	US-5,832,182	11-1998	Zhang et al.	706/50
	D	US-2002/0165837	11-2002	Zhang et al.	706/16
	E	US-6,003,029	12-1999	Agrawal et al.	707/7
	F	US-6,092,072	07-2000	Guha et al.	707/101
	G	US-6,115,708	09-2000	Fayyad et al.	707/6
	H	US-6,336,082	01-2002	Nguyen et al.	702/179
	I	US-6,571,227	05-2003	Agrafiotis et al.	706/15
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Srikant et al., "Research Report: Mining Sequential Patterns: Generalizations and Performance Improvements", Proceedings o the 5th International Conference on Extending Database Technology, 1996, Vol. 1057, pages 3-17.
	V	Guha et al., "CURE: An Efficient Clustering Algorithm for Large Databases", International Conference on Management of Data and Symposium on Principles of Database Systems, 1998, pages 73-84.
	W	Knorr et al., "A Unified Approach for Mining Outliers", Proceedings of the 1997 Conference of the Centre for Advanced Studies on Collaborative Research, 1997.
	X	Becker et al., "The Maximum Asymptotic Bias of Outlier Identifiers", NEC Research Index, 1997, Retrieved from the Internet: http://citeseer.nj.nec.com/becker97maximum.html.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Nasraoui et al., "A Robust Estimator Based on Density and Scale Optimization and its Application to Clustering", Proceedings o the 5th IEEE International Conference on Fuzzy Systems, September 1996, Vol. 2, pages 1031-1035. /
	V	Maiyuran et al., "A Cluster Based Approach to Robust Regression and Outlier Detection", 1994 Intl. Conf. on Systems, Man an Cybernetics, October 1994, Vol. 3, pages 2561-2565. /
	W	Knorr et al., "Distance-based Outliers: Algorithms and Applications", The VLDB Journal, Vol. 8, Iss. 3-4, February 2000, pages 237-253. /
	X	Shanmugasundaram et al., "Compressed Data Cubes for OLAP Aggregate Query Apporximation on Continuous Dimensions", Proceedings of the 5th ACM SIGKDD Intl Conf on Knowledge Discovery and Data Mining, 1999, pages 223-232.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sheikholeslami et al., "WaveCluster: A Wavelet-Based Clustering Approach For Spatial Data in Very Large Databases", The VLDB Journal, Vol. 8, Iss. 3-4, February 2000, pages 289-304
	V	Palpanas, T., "Knowledge Discovery in Data Warehouses", ACM SIGMOD Record, Vol. 29, Iss. 3, September 2000, pages 88 100.
	W	Kunz et al., "Fast Detection of Communication Patterns in Distributed Executions", Proceedings of the 1997 Conf of the Centre for Advanced Studies on Collaborative Research, 1997, page 12.
	X	Aggarwal et al., "On the Merits of Building Categorization Systems by Supervised Clustering", Proceedings of the 5th ACM SIGKDD Intl Conf on Knowledge Discovery and Data Mining, 1999, pages 352-356.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Jain et al., "Data Clustering: A Review", ACM Computing Surveys, Vol. 31, No. 3, September 1999, pages 264-323.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.